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ON Semiconductor®

FGB3056-F085

EcoSPARK® 300mJ, 560V, N-Channel Ignition IGBT

Features

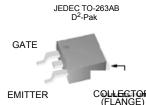
- SCIS Energy = 300mJ at T_J = 25°C
- Logic Level Gate Drive

Applications

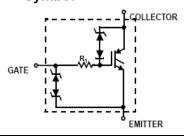
- Automotive Ignition Coil Driver Circuits
- Coil On Plug Applications



Package



Symbol



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 2mA)		560	V
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = -20m	nA)	20	V
E _{SCIS25}	I_{SCIS} = 14.2A, L = 3.0mHy, R_{GE} = 1K Ω	T _C = 25°C	300	mJ
E _{SCIS150}	I_{SCIS} = 10.8A, L = 3.0mHy, R_{GE} = 1K Ω	T _C = 150°C	170	mJ
I _{C25}	Collector Current Continuous, at V _{GE} = 5V, T _C = 25°C	29	Α	
I _{C110}	Collector Current Continuous, at V _{GE} = 5V, T _C = 110°C		24	Α
V_{GEM}	Gate to Emitter Voltage Continuous		±10	V
D	Power Dissipation Total, at T _C = 25°C	T _C = 25°C	200	W
P_{D}	Power Dissipation Derating, for T _C > 25°C	T _C > 25°C	1.33	W/°C
T_J	Operating Junction Temperature Range		-40 to +175	°C
T _{STG}	Storage Junction Temperature Range		-40 to +175	°C
T _L	Max. Lead Temp. for Soldering (Leads at 1.6mm from case for 10s	300	°C	
T _{PKG}	Reflow soldering according to JESD020C		260	°C
ESD	HBM-Electrostatic Discharge Voltage at100pF, 1500Ω		4	kV

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case	0.75	°C/W	
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Electrical Characteristics of the IGBT T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
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Off State Characteristics

BV _{CER}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V, I_{CE} = 2mA,$ $R_{GE} = 1K\Omega,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		530	560	600	٧
BV _{CES}	Collector to Emitter Breakdown Voltage	$V_{GE} = 0V, I_{CE} = 10mA,$ $R_{GE} = 0\Omega,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		-	595	-	٧
BV _{ECS}	Emitter to Collector Breakdown Voltage	$V_{GE} = 0V, I_{CE} = -75mA,$ $T_{J} = 25^{\circ}C$		20	26	-	V
BV_{GES}	Gate to Emitter Breakdown Voltage	I_{GES} = ±5mA		±12	±14	-	V
1	Collector to Emitter Leakage Current	V_{CE} = 250V, R_{GE} = 1K Ω	$T_{J} = 25^{\circ}C$	-	-	40	μА
I _{CER}	Collector to Emitter Leakage Current		$T_{J} = 150^{\circ}C$	-	-	1	mA
1	Emitter to Collector Leakage Current	V _{EC} = 20V	$T_{J} = 25^{\circ}C$	-	-	1	mA
I _{ECS}	Limiter to Conector Leakage Current		$T_{\rm J} = 150^{\rm o}{\rm C}$	-	-	40	IIIA
R ₁	Series Gate Resistance			-	100	-	Ω

On State Characteristics

V _{CE(SAT)}	Collector to Emitter Saturation Voltage	V _{GE} = 5V, I _{CE} = 2A	$T_{J} = 25^{\circ}C$	-	1.0	1.1	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	V_{GE} = 5V, I_{CE} = 8A	$T_{\rm J} = 150^{\rm o}{\rm C}$	-	1.3	1.55	V

Dynamic Characteristics

Q _{G(ON)}	Gate Charge	V _{GE} = 5V, V _{CE} = 12V, I _{CE} = 10A		-	15.6	20	nC
V	Gate to Emitter Threshold Voltage	= 1mΛ \/ = \/	$T_{J} = 25^{\circ}C$	1.3	1.6	2.2	V
V _{GE(TH)}	Gate to Emitter Threshold Voltage	I_{CE} = 1mA, V_{CE} = V_{GE} ,	$T_{J} = 150^{\circ}C$	-	1.1	-	v
V_{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12V, I _{CE} = 10A		-	2.8	-	V

Switching Characteristics

$t_{d(ON)R}$	Current Turn-On Delay Time-Resistive	V_{CE} = 14V, R_L = 1 Ω	-	8.0	1.3	μS
t_{rR}	Current Rise Time-Resistive	$V_{GE} = 5V, R_G = 1K\Omega$	-	1.48	2.4	μS
t _{d(OFF)L}	Current Turn-Off Delay Time-Inductive	V _{CE} = 300V, L = 1mH,	-	5.1	8.2	μS
t_{fL}	Current Fall Time-Inductive	$V_{GE} = 5V, R_G = 1K\Omega$	-	1.1	1.8	μS

Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FGB3056	FGB3056-F085	TO-263AB	330mm	24mm	800units

Typical Performance Curves

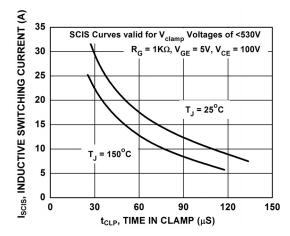


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

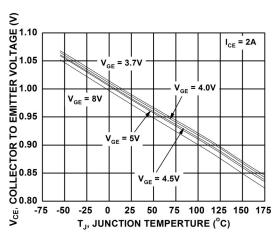


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

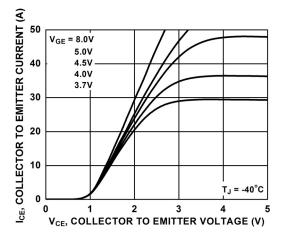


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

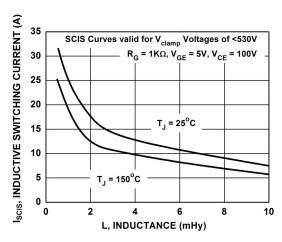


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

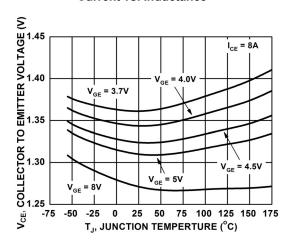


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

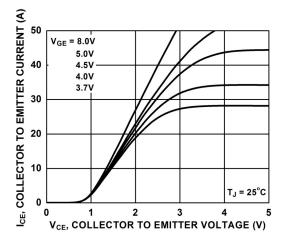


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current



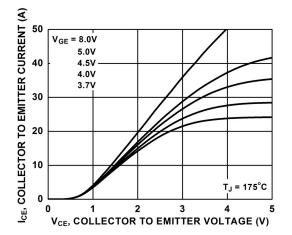


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

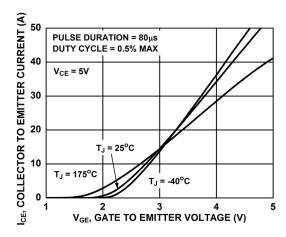


Figure 8. Transfer Characteristics

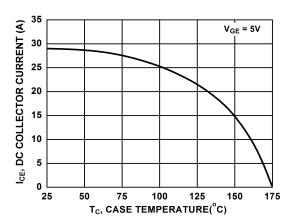


Figure 9. DC Collector Current vs. Case Temperature

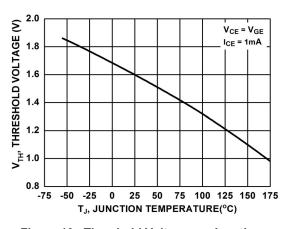


Figure 10. Threshold Voltage vs. Junction Temperature

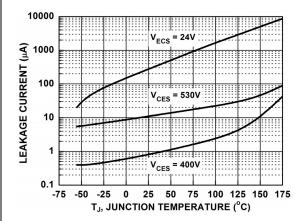


Figure 11. Leakage Current vs. Junction Temperature

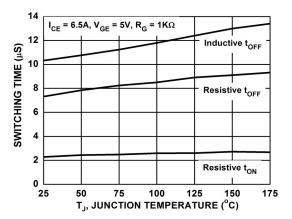
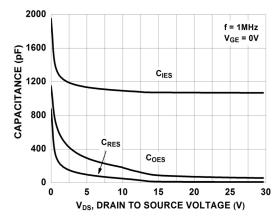


Figure 12. Switching Time vs. Junction Temperature

Typical Performance Curves (Continued)



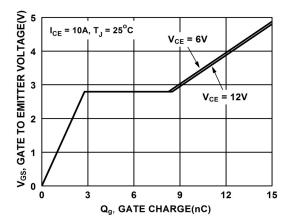


Figure 13. Capacitance vs. Collector to Emitter Voltage

Figure 14. Gate Charge

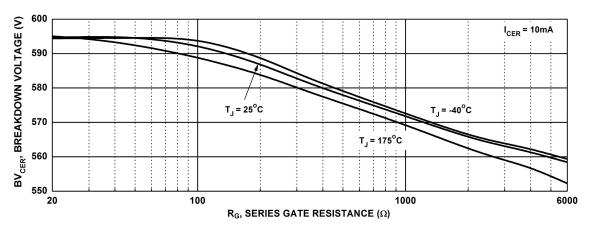


Figure 15. Break down Voltage vs. Series Gate Resistance

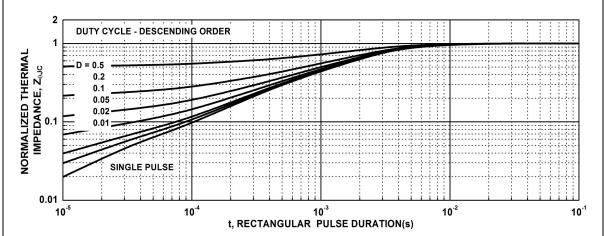


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

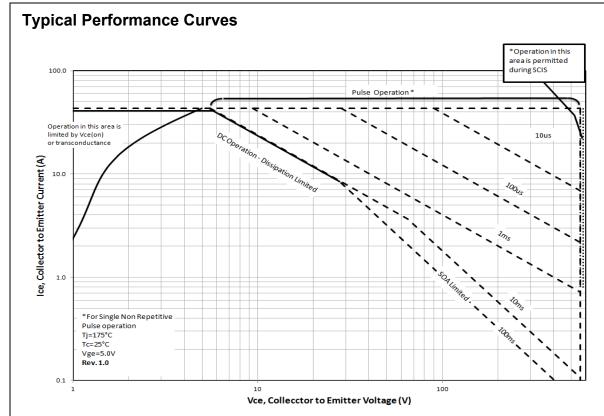


Figure 17. Forward Safe Operating Area

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